

VOLTAGE COMPARATOR

SE/NE529

DESCRIPTION

The SE/NE529 is a high speed analog voltage comparator which, for the first time mates state-of-the-art Schottky diode technology with the conventional linear process. This allows simultaneous fabrication of high speed T2L gates with a precision linear amplifier on a single monolithic chip.

FEATURES

- 10ns propagation delay
- Complementary output gates
- TTL or ECL compatible outputs
- Wide common mode and differential voltage range
- Typical Gain 5000

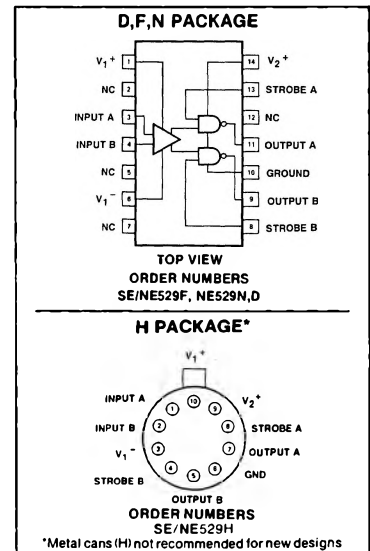
APPLICATIONS

- A/D conversion
- ECL to TTL interface
- TTL to ECL interface
- Memory sensing
- Optical data coupling
- Mil std 883A,B,C available

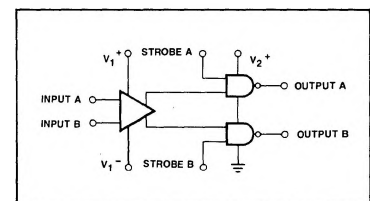
ABSOLUTE MAXIMUM RATINGS

PARAMETER	RATING	UNIT
Positive supply voltage (V1+)	+15	V
Negative supply voltage (V1-)	-15	V
Gate supply voltage (V2+)	+7	V
Output voltage	+7	V
Differential input voltage	±5	V
Input common mode voltage	±6	V
Power dissipation	600	mW
Operating temperature range		
NE529	0 to +70	°C
SE529	-55 to +125	°C
Storage temperature range	-65 to +150	°C
Lead temperature		
(soldering, 60 sec)	+300	°C

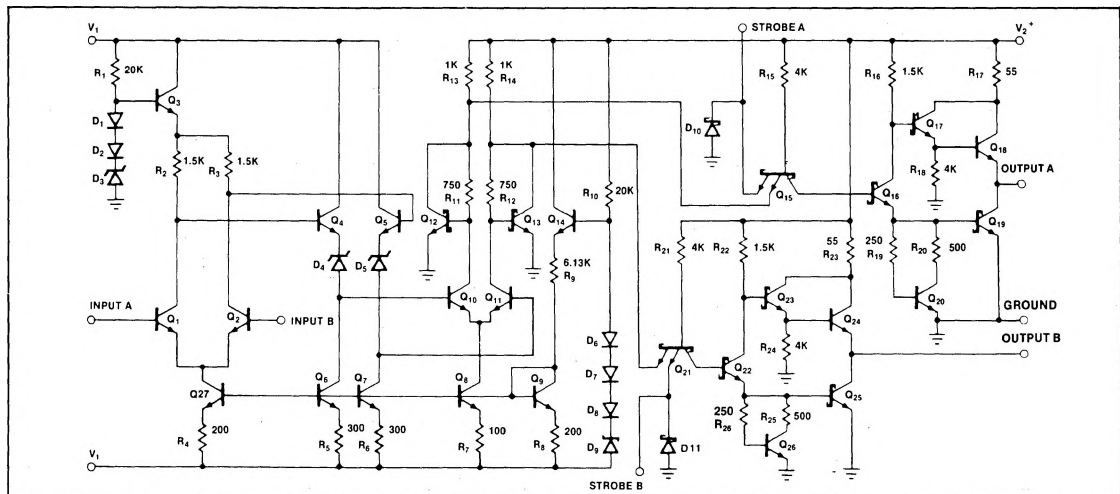
PIN CONFIGURATION



BLOCK DIAGRAM



EQUIVALENT SCHEMATIC



VOLTAGE COMPARATOR

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DC ELECTRICAL CHARACTERISTICS $V_{1+} = +10V$, $V_{2+} = +5.0V$, $V_{1-} = -10V$

PARAMETER	TEST CONDITIONS	SE529			NE529			UNIT
		Min	Typ	Max	Min	Typ	Max	
INPUT CHARACTERISTICS								
Input offset voltage @25°C				4			6	mV
Over temperature range				6			10	mV
Input bias current @25°C	$V_{IN} = 0V$		5	12		5	20	μA
Over temperature range				36			50	μA
Input offset current @25°C	$V_{IN} = 0V$		2	3		2	5	μA
Over temperature range				9			15	μA
Common mode voltage range			0	± 5		0	± 5	V
GATE CHARACTERISTICS								
Output voltage								
"1" state	$V_{2+} = 4.75V$, $I_{source} = -1mA$	2.5	3.3		2.7	3.3		V
"0" state	$V_{2+} = 4.75V$, $I_{sink} = 10mA$			0.5			0.5	V
Strobe inputs								
"0" Input current ¹	$V_{2+} = 5.25V$, $V_{strobe} = 0.5V$			-2			-2	mA
"1" Input current @ 25°C ¹	$V_{2+} = 5.25V$, $V_{strobe} = 2.7V$			50			100	μA
Over temperature range	$V_{2+} = 5.25V$, $V_{strobe} = 2.7V$			200			200	μA
"0" input voltage	$V_{2+} = 4.75V$			0.8			0.8	V
"1" input voltage	$V_{2+} = 4.75V$	2.0			2.0			V
Short circuit								
Output current	$V_{2+} = 5.25V$, $V_{OUT} = 0V$	-18		-70	-18		-70	mA
POWER SUPPLY REQUIREMENTS								
Supply voltage								
V_{1+}		5		10	5		10	V
V_{1-}		-6		-10	-6		-10	V
V_{2+}		4.5	5	5.5	4.75	5	5.25	V
Supply current	$V_{1+} = 10V$, $V_{1-} = -10V$ $V_{2+} = 5.25V$							
I_{1+}	Over temp.			5			5	mA
I_{1-}	Over temp.			10			10	mA
I_{2+}	Over temp.			20			20	mA

NOTES

1. See logic function table.

AC ELECTRICAL CHARACTERISTICS $T_A = 25^\circ C$

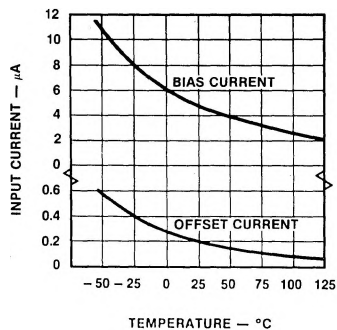
PARAMETER	TEST CONDITIONS	LIMITS			UNIT
		Min	Typ	Max	
Transient response	$V_{IN} = \pm 100mV$ step				
Propagation delay time					
t_{PLH}			12	22	ns
t_{PHL}			10	20	ns
Delay between output			2	5	ns
A and B					
Strobe delay time					
t_{ON} turn-on time			6		ns
t_{OFF} turn-off time			6		ns

VOLTAGE COMPARATOR

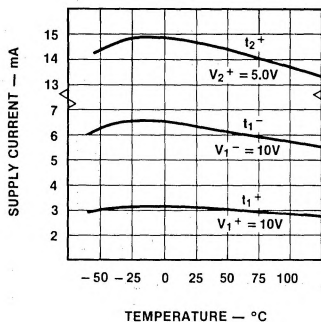
SE/NE529

TYPICAL PERFORMANCE CHARACTERISTICS

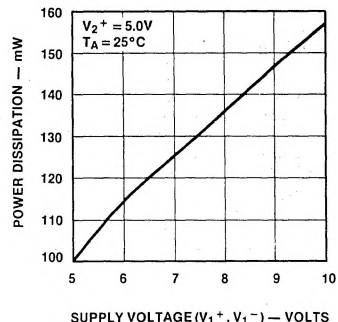
**INPUT CURRENTS
vs TEMPERATURE**



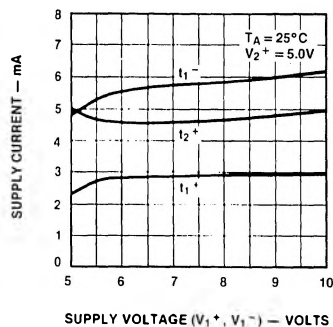
**SUPPLY CURRENT
vs TEMPERATURE**



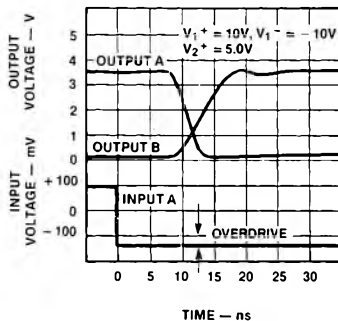
**POWER DISSIPATION
vs SUPPLY VOLTAGE**



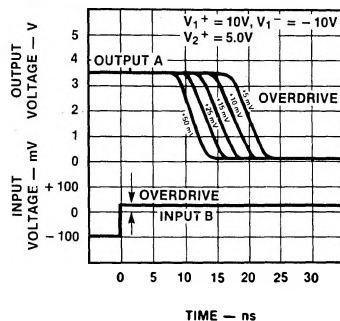
**SUPPLY CURRENT
vs SUPPLY VOLTAGE**



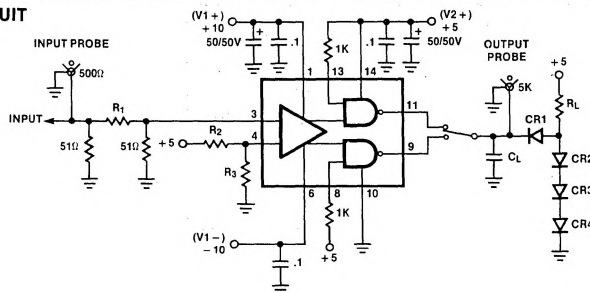
OUTPUT PROPAGATION DELAYS



**RESPONSE TIME FOR
VARIOUS INPUT OVERDRIVES**



RESPONSE TIME TEST CIRCUIT



CR1 - CR4 = IN914
R1 SELECTED FOR 15:1 DIVIDER
R2,3 SELECTED FOR 100mV AT PIN 4

INPUT
PRR = 1MHz
PW = 50ns
Tr = Tl = 2ns
AMPLITUDE = 3.00V

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APPLICATIONS

One of the main features of the device is that supply voltages (V_{1+} , V_{1-}) need not be balanced, as indicated in the following diagrams. For proper operation, however, negative supply (V_{1-}) should always be at least six volts more negative than the ground terminal (pin 6). Input Common Mode range should be limited to values of two volts less than the supply voltages (V_{1+} and V_{1-}) up to a maximum of ± 6 volts as supply voltages are increased.

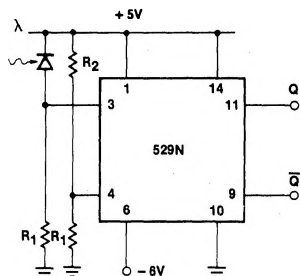
It is also important to note that Output A is in phase with Input A and Output B is in phase with Input B.

NE529 LOGIC FUNCTION

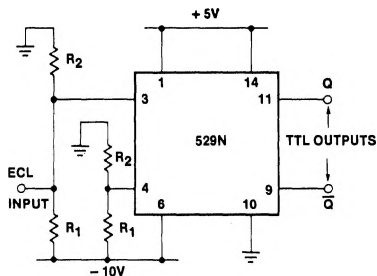
V_{IN} (A ⁺ , B ⁻)	STR 'A'	STR 'B'	OUT 'A'	OUT 'B'	COMMENT
$> V_{off}$	X	h/l	H	l/h	Read I_{ILB} , I_{IHA}
$< -V_{off}$	h/l	X	l/h	H	Read I_{ILA} , I_{IHB}

TYPICAL APPLICATIONS

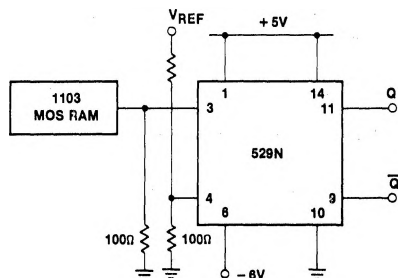
PHOTODIODE DETECTOR



ECL TO TTL INTERFACE



MOS MEMORY SENSE AMP



TTL TO ECL INTERFACE

